Notic of References Cit d

Application/Control No. 09/499,442	R	pplicant(s)/Pater eexamination REER ET AL.	nt Under	
Examiner	A	rt Unit		
Nhon (Garv) D Nguyen	2	174	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,850,218	12-1998	LaJoie et al	725/45
	В	US-6,320,599	11-2001	Sciammarella et al	345/667
	С	US-5,940,073	08-1999	Klosterman et al	345/721
	D	US-6,208,388	03-2001	Farleigh	348/705
	E	US-6,204,884	03-2001	Lee	348/555
	F	US-6,182,094	01-2001	Humpleman	707/513
	G	US-6,084,638	07-2000	Hare et al	348/552
	н	US-5,787,259	07-1998	Haroun et al	709/253
	1	US-6,177,963	01-2002	Foye et al	348/706
	J.	US-6,359,636	03-2002	Schindler et al	345/846
	К	US-5,815,631	09-1998	Sugiyama et al	386/46
<u> </u>	L	US-6,163,316	12-2000	Killian	345/721
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					<u> </u>
	R					
	S					
	Т		*			

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.